# International Rectifier

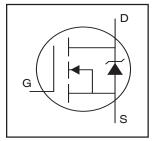
### **AUTOMOTIVE GRADE**

# AUIRF1324

HEXFET® Power MOSFET

### **Features**

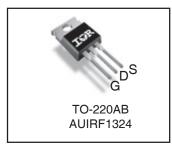
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



V <sub>DSS</sub>	24V
R <sub>DS(on)</sub> typ.	1.2m $\Omega$
max.	1.5m $\Omega$
I <sub>D (Silicon Limited)</sub>	353A①
I <sub>D (Package Limited)</sub>	195A

### **Description**

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



G	D	S
Gate	Drain	Source

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T<sub>A</sub>) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	<b>353</b> ①	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	249 ①	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	195	7 ^
I <sub>DM</sub>	Pulsed Drain Current ②	1412	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	300	W
	Linear Derating Factor	2.0	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 3	270	mJ
I <sub>AR</sub>	Avalanche Current ②	See Fig. 14, 15, 22a, 22b	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ③		mJ
dv/dt	Peak Diode Recovery @	0.46	V/ns
$T_J$	Operating Junction and	FF 4 17F	
T <sub>STG</sub>	Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	

### Thermal Resistance

Symbol	Symbol Parameter		Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		0.50	
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient		62	1

HEXFET® is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/



### Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	24	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		22		mV/°C	Reference to 25°C, I <sub>D</sub> = 5.0mA <sup>②</sup>
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance	_	1.2	1.5	mΩ	$V_{GS} = 10V, I_D = 195A $ ⑤
$V_{GS(th)}$	Gate Threshold Voltage	2.0	_	4.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
gfs	Forward Transconductance	180			S	$V_{DS} = 10V, I_{D} = 195A$
$R_G$	Internal Gate Resistance		2.3		Ω	
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 24V, V_{GS} = 0V$
			_	250		$V_{DS} = 24V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			200	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-200		$V_{GS} = -20V$

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

•	· · · · · · · · · · · · · · · · · · ·	•			•	,
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$Q_g$	Total Gate Charge		160	240		I <sub>D</sub> = 195A
$Q_{gs}$	Gate-to-Source Charge		84		nC	$V_{DS} = 12V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		49		IIC	V <sub>GS</sub> = 10V ⑤
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		76			$I_D = 195A, V_{DS} = 0V, V_{GS} = 10V$
t <sub>d(on)</sub>	Turn-On Delay Time		17			$V_{DD} = 16V$
t <sub>r</sub>	Rise Time		190			I <sub>D</sub> = 195A
t <sub>d(off)</sub>	Turn-Off Delay Time		83		ns	$R_G = 2.7\Omega$
t <sub>f</sub>	Fall Time		120			V <sub>GS</sub> = 10V ⑤
C <sub>iss</sub>	Input Capacitance		7590			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		3440			$V_{DS} = 24V$
C <sub>rss</sub>	Reverse Transfer Capacitance		1960		рF	f = 1.0  MHz,  See Fig. 5
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)		4700			$V_{GS} = 0V$ , $V_{DS} = 0V$ to 19V $\bigcirc$ , See Fig. 11
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related)		4490			V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 19V ©

### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			<b>353</b> ①		MOSFET symbol
	(Body Diode)			33	Α	showing the
I <sub>SM</sub>	Pulsed Source Current			1412	^	integral reverse
	(Body Diode) ②			1712		p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	>	$T_J = 25$ °C, $I_S = 195A$ , $V_{GS} = 0V$ $\$$
t <sub>rr</sub>	Reverse Recovery Time		46		20	$T_J = 25^{\circ}C$ $V_R = 20V$ ,
			71		ns	$T_J = 125^{\circ}C$ $I_F = 195A$
Q <sub>rr</sub>	Reverse Recovery Charge		160		nC	$T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s $\odot$
			430		IIC	$T_J = 125$ °C
I <sub>RRM</sub>	Reverse Recovery Current		7.7		Α	$T_J = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

### Notes:

- ① Calcuted continuous current based on maximum allowable junction temperature Bond wire current limit is 195A. Note that current limitation arising from heating of the device leds may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- $\textcircled{4} \quad I_{SD} \leq 195 A, \ di/dt \leq 450 \ A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_{J} \leq 175 ^{\circ} C.$

- © C<sub>oss</sub> eff. (TR) is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- $\odot$  C<sub>oss</sub> eff. (ER) is a fixed capacitance that gives the same energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- $\ensuremath{\$}\ R_{\theta}$  is measured at T\_J approximately 90°C

## Qualification Information<sup>†</sup>

			Automotive			
		(per AEC-Q101) <sup>††</sup>				
Qualification L	.evel	Comments: This part number(s) passed Automotive qualification IR's Industrial and Consumer qualification level is granted extension of the higher Automotive level.				
Moisture Sensitivity Level		D2Pak MSL1				
			N/A			
	Machine Model		Class M4			
		AEC-Q101-002				
FOD	Human Body Model	Class H3A				
ESD		AEC-Q101-001				
	Charged Device Model	Class C5				
		AEC-Q101-005				
RoHS Complia	int	Yes				

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

<sup>††</sup> Exceptions to AEC-Q101 requirements are noted in the qualification report.

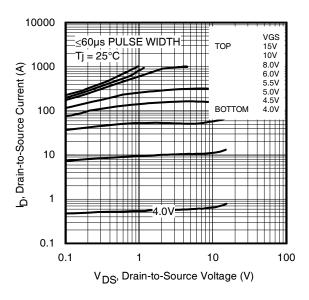


Fig 1. Typical Output Characteristics

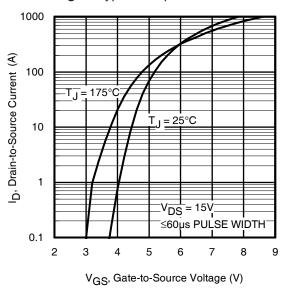
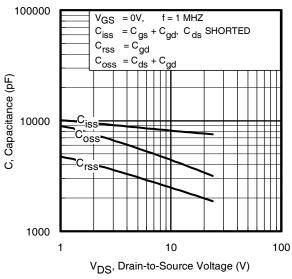


Fig 3. Typical Transfer Characteristics



**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage 4

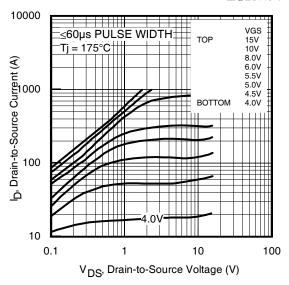


Fig 2. Typical Output Characteristics

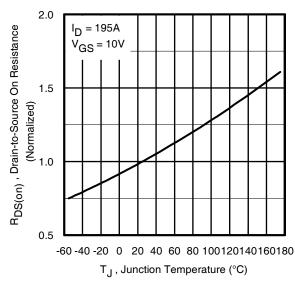
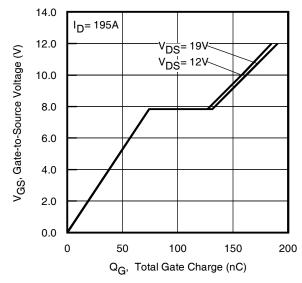


Fig 4. Normalized On-Resistance vs. Temperature



**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage www.irf.com

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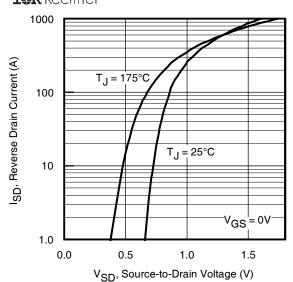
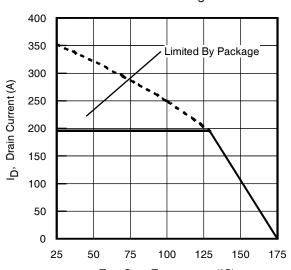
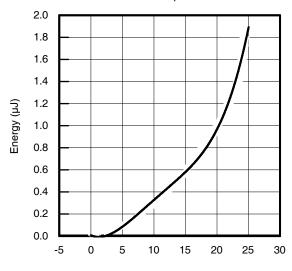


Fig 7. Typical Source-Drain Diode Forward Voltage



T<sub>C</sub>, Case Temperature (°C) **Fig 9.** Maximum Drain Current vs.

Case Temperature



 $\label{eq:VDS} $$V_{DS}$, Drain-to-Source Voltage (V) $$Fig 11. Typical $C_{OSS}$ Stored Energy $$www.irf.com$ 

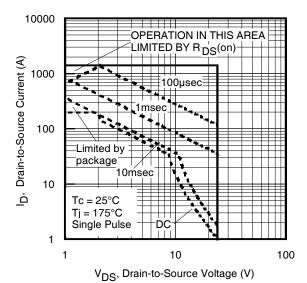


Fig 8. Maximum Safe Operating Area

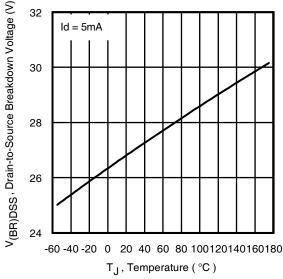


Fig 10. Drain-to-Source Breakdown Voltage

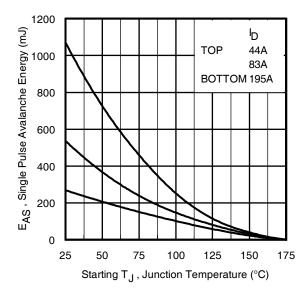


Fig 12. Maximum Avalanche Energy vs. DrainCurrent

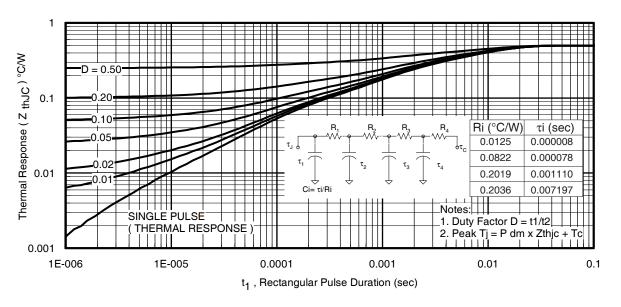
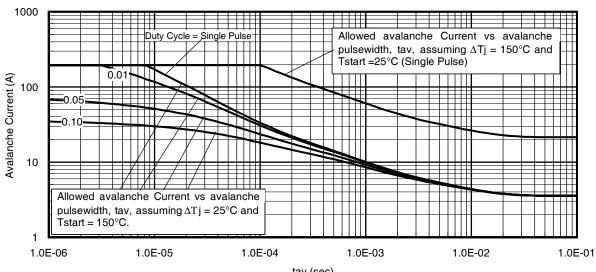


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case



tav (sec) **Fig 14.** Typical Avalanche Current vs.Pulsewidth

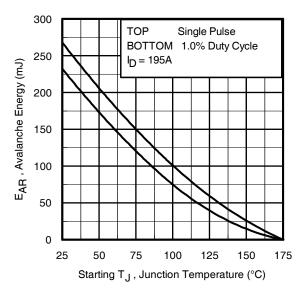


Fig 15. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves, Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{\rm jmax}$ . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT<sub>imax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4.  $P_{D (ave)}$  = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).

 $t_{av}$  = Average time in avalanche.

 $D = Duty cycle in avalanche = t_{av} \cdot f$ 

 $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \triangle T / \; Z_{thJC} \\ I_{av} &= 2\triangle T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

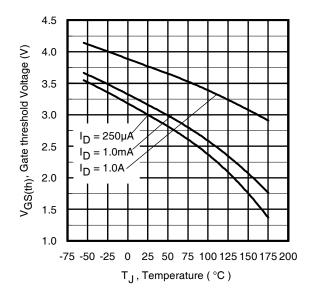


Fig 16. Threshold Voltage vs. Temperature

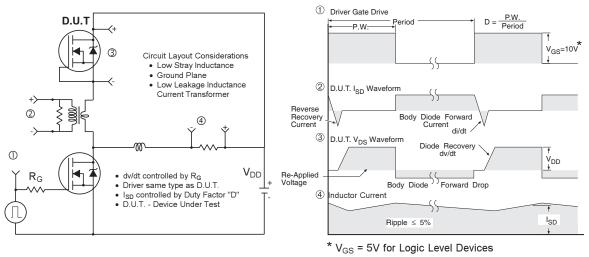


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel

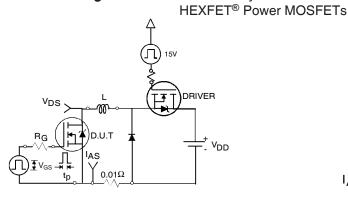


Fig 22a. Unclamped Inductive Test Circuit

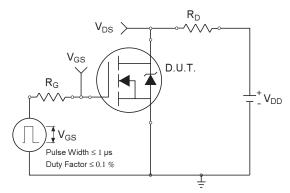


Fig 23a. Switching Time Test Circuit

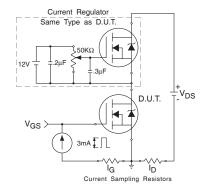


Fig 24a. Gate Charge Test Circuit

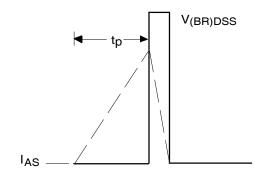


Fig 22b. Unclamped Inductive Waveforms

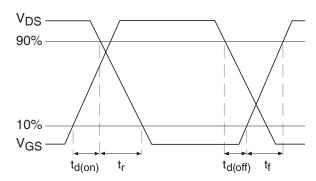


Fig 23b. Switching Time Waveforms

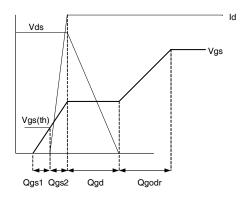
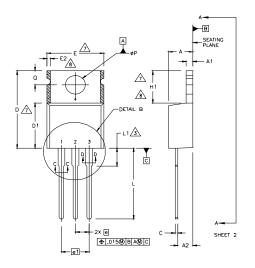
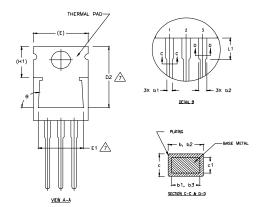


Fig 24b. Gate Charge Waveform

### TO-220AB Package Outline

Dimensions are shown in millimeters (inches)





- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS], LEAD DIMENSION AND FINISH UNCONTROLLED IN L1
- DMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH
  SHALL NOT EXCEED .005" (0,127) PER SIDE, THESE DIMENSIONS ARE
  MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY,
- DIMENSION 61 & c1 APPLY TO BASE METAL ONLY, CONTROLLING DIMENSION: INCHES.

12.70

3.54

2,54

L1

øΡ

Q

14.73

6.35

4.08

3.42

.500

139

.100

.580

.250

.161

.135

3

- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.

SYMBOL	MILLIMETERS		INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	3.56	4.82	.140	.190	
A1	0.51	1,40	.020	.055	
A2	2.04	2.92	.080	.115	
b	0.38	1,01	.015	.040	
b1	0.38	0.96	.015	.038	5
b2	1.15	1,77	.045	.070	
b3	1.15	1.73	.045	.068	
С	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	12.19	12.88	.480	.507	7
E	9.66	10.66	.380	.420	4,7
E1	8.38	8.89	.330	.350	7
e	2.54 BSC		.100	BSC	
e1		08	,200	BSC	
H1	5.85	6.55	.230	.270	7,8

### LEAD ASSIGNMENTS

#### HEXFET

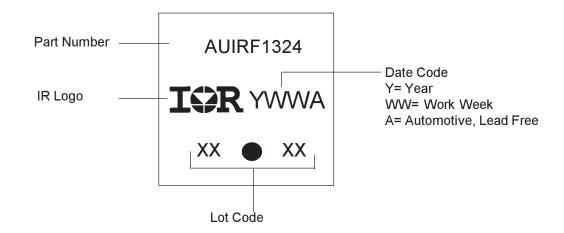
#### IGBTs, CoPACK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER

# DIODES

- 1.- ANODE/OPEN 2.- CATHODE 3.- ANODE

# TO-220AB Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

# **Ordering Information**

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRF1324	TO-220	Tube	50	AUIRF1324



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http://www.irf.com/technical-info/

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